



#### **COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET**

# **Product Summary**

Device	V <sub>(BR)DSS</sub>	R <sub>DS(on) max</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
Q2	40V	$24m\Omega$ @ $V_{GS}$ = $10V$	9.0A
Q2	400	$32mΩ$ @ $V_{GS} = 4.5V$	7.8A
Q1	-40V	$45$ m $\Omega$ @ V <sub>GS</sub> = -10V	-6.5A
	- <del>4</del> 0V	55mΩ @ V <sub>GS</sub> = -4.5V	-5.9A

# Description

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

# **Applications**

- DC-DC Converters
- Power Management Functions
- Backlighting

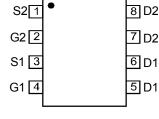
# **Features and Benefits**

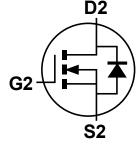
- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

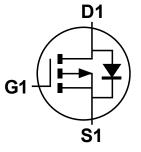
#### **Mechanical Data**

- Case: SO-8
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Tin Finish annealed over Copper leadframe.
  Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.074 grams (approximate)









Top View

TOP VIEW Internal Schematic

N-Channel MOSFET

P-Channel MOSFET

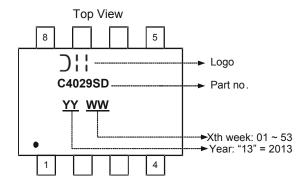
#### Ordering Information (Note 4 & 5)

Part Number	Compliance	Case	Packaging
DMC4029SSD-13	Standard	SO-8	2,500/Tape & Reel
DMC4029SSDQ-13	Automotive	SO-8	2,500/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. Automotive products are AEC-Q101 qualified and are PPAP capable. Automotive, AEC-Q101 and standard products are electrically and thermally the same, except where specified. For more information, please refer to http://www.diodes.com/quality/product\_grade\_definitions/.
- 5. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**





# Maximum Ratings (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value_Q2	Value_Q1	Units		
Drain-Source Voltage		$V_{DSS}$	40	-40	V	
Gate-Source Voltage	$V_{GSS}$	±20	±20	V		
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			I <sub>D</sub>	7.0 5.6	-5.1 -4.1	Α
Continuous Drain Current (Note 7) V <sub>GS</sub> = 10V	t<10s	T <sub>A</sub> = +25°C T <sub>A</sub> = +70°C	I <sub>D</sub>	9.0 7.2	-6.5 -5.2	Α
Maximum Body Diode Forward Current (Note 7)	Is	2.5	-2.5	Α		
Pulsed Drain Current (10µs pulse, duty cycle = 1	$I_{DM}$	70	-40	Α		

# Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	C	1.3	W
Total Fower Dissipation (Note 6)	T <sub>A</sub> = +70°C	$P_{D}$	0.8	
Thermal Resistance, Junction to Ambient (Note 6)	Steady state	C	98	°C/W
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{\theta JA}$	59	
Total Power Dissipation (Note 7)	T <sub>A</sub> = +25°C	Pn	1.8	W
Total Fower Dissipation (Note 7)	T <sub>A</sub> = +70°C	PD	1.1	
Thermal Resistance, Junction to Ambient (Note 7)	Steady state	C	71	°C/W
Thermal Resistance, Junction to Ambient (Note 7)	t<10s	$R_{\theta JA}$	43	
Thermal Resistance, Junction to Case (Note 7)		Rejc	11.8	
Operating and Storage Temperature Range		$T_{J_i} T_{STG}$	-55 to +150	°C

# Electrical Characteristics N-Channel Q2 (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	40		_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	1	μΑ	V <sub>DS</sub> = 40V, V <sub>GS</sub> = 0V	
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	1.0	_	3.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance		_	15	24	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 6A	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	20	32	11177	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5A	
Diode Forward Voltage	$V_{SD}$	_	0.7	1.0	V	V <sub>GS</sub> = 0V, I <sub>S</sub> = 1.0A	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C <sub>iss</sub>		1060	_		V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V, f = 1.0MHz	
Output Capacitance	Coss		84	_	pF		
Reverse Transfer Capacitance	C <sub>rss</sub>	_	58	_			
Gate Resistance	$R_G$	_	1.6	_	Ω	V <sub>DS</sub> = 0V, V <sub>GS</sub> = 0V, f = 1.0MHz	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	_	8.8	_			
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_g$	_	19.1	_	nC	\\ - 20\\ I - 0A	
Gate-Source Charge	$Q_{gs}$	_	3.0	_	IIC	$V_{DS} = 20V, I_{D} = 8A$	
Gate-Drain Charge	$Q_{gd}$	_	2.5	_			
Turn-On Delay Time	t <sub>D(on)</sub>	_	5.3	_			
Turn-On Rise Time	t <sub>r</sub>	_	7.1	_	nS	$V_{DD}$ = 25V, $R_{L}$ = 2.5 $\Omega$ $V_{GS}$ = 10V, $R_{G}$ = 3 $\Omega$	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	15.1	_	115		
Turn-Off Fall Time	t <sub>f</sub>	_	4.8	_			
Body Diode Reverse Recovery Time	t <sub>rr</sub>		10.5		nS	I <sub>F</sub> = 8A, di/dt = 100A/μs	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>		4.15	_	nC	I <sub>F</sub> = 8A, di/dt = 100A/μs	



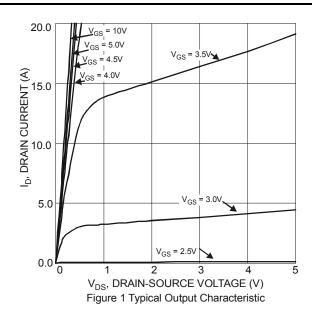
# Electrical Characteristics P-Channel Q1 (@TA = +25°C, unless otherwise specified.)

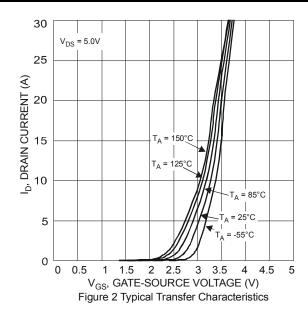
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition		
OFF CHARACTERISTICS (Note 8)								
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-40	_	_	V	$V_{GS} = 0V, I_D = -250\mu A$		
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	_	_	-1	μA	V <sub>DS</sub> = -40V, V <sub>GS</sub> = 0V		
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$		
ON CHARACTERISTICS (Note 8)								
Gate Threshold Voltage	V <sub>GS(th)</sub>	-1.0	_	-3.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$		
Static Drain-Source On-Resistance		_	33	45	<b>m</b> O	$V_{GS} = -10V, I_D = -5A$		
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	_	40	55	mΩ	$V_{GS} = -4.5V, I_D = -4A$		
Diode Forward Voltage	$V_{SD}$	_	-0.7	-1.0	V	$V_{GS} = 0V, I_{S} = -1.0A$		
DYNAMIC CHARACTERISTICS (Note 9)								
Input Capacitance	C <sub>iss</sub>	_	1154			V <sub>DS</sub> = -20V, V <sub>GS</sub> = 0V f = 1.0MHz		
Output Capacitance	Coss	_	84	_	pF			
Reverse Transfer Capacitance	C <sub>rss</sub>	_	66	_				
Gate Resistance	$R_G$	_	12.6	_	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$		
Total Gate Charge (V <sub>GS</sub> = -4.5V)	Qg	_	10.6	_				
Total Gate Charge (V <sub>GS</sub> = -10V)	$Q_g$	_	21.5	_	nC	VDS = -20V, ID = -4.9A		
Gate-Source Charge	Q <sub>gs</sub>	_	2.2	_	IIC			
Gate-Drain Charge	$Q_{gd}$	_	3.3	_				
Turn-On Delay Time	t <sub>D(on)</sub>	_	8.7	_		V <sub>DS</sub> = -20V, I <sub>D</sub> = -3.9A V <sub>GS</sub> = -4.5V, R <sub>G</sub> = 1Ω		
Turn-On Rise Time	t <sub>r</sub>	_	19.6	_	nS			
Turn-Off Delay Time	t <sub>D(off)</sub>	_	34.9	_	113			
Turn-Off Fall Time	t <sub>f</sub>	_	25.5	_				
Body Diode Reverse Recovery Time	t <sub>rr</sub>	_	9.61	_	nS	I <sub>S</sub> = -3.9A, dI/dt = 100A/μs		
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	_	3.3	_	nC	I <sub>S</sub> = -3.9A, dI/dt = 100A/μs		

Notes:

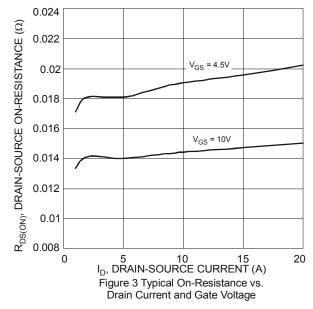
- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
- 7. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
- 8. Short duration pulse test used to minimize self-heating effect.
- 9. Guaranteed by design. Not subject to product testing.

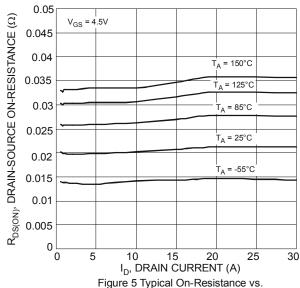
#### N-Channel Q2

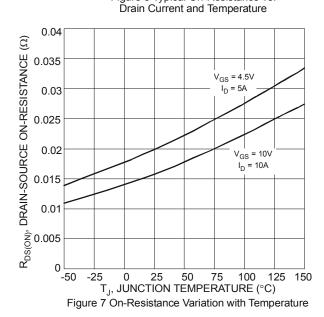


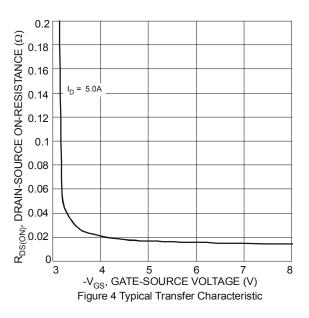












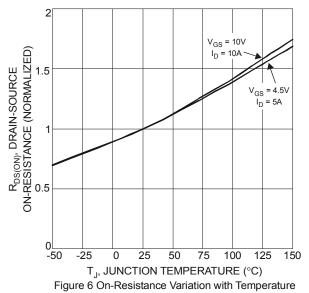
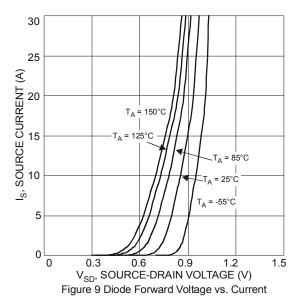
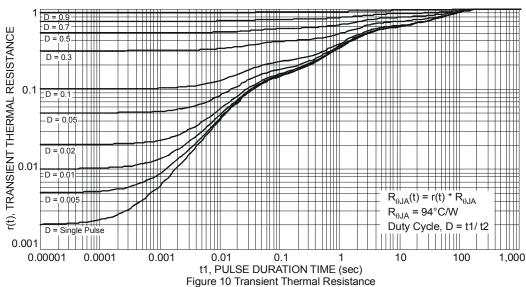


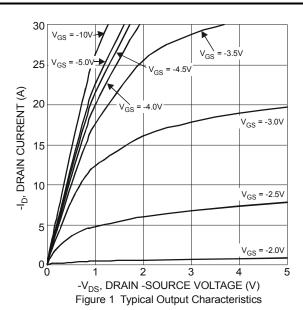
Figure 8 Gate Threshold Variation vs. Ambient Temperature

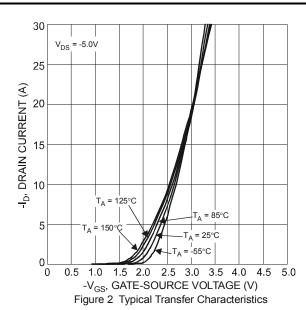




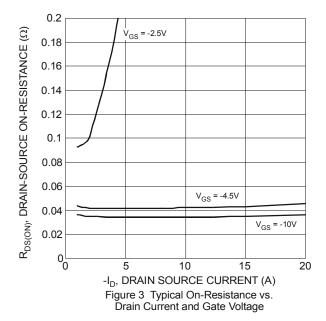


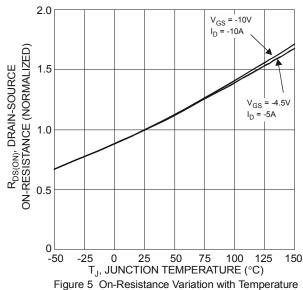
### P-Channel Q1











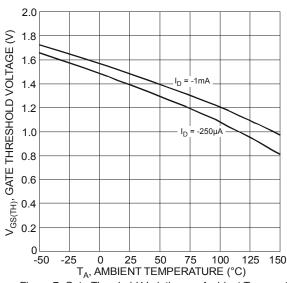
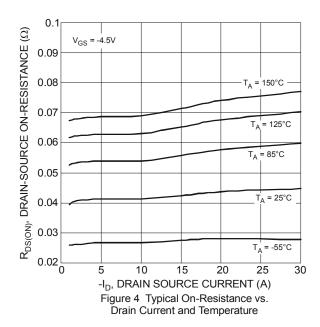
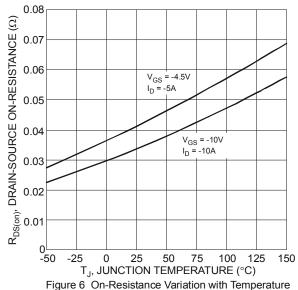


Figure 7 Gate Threshold Variation vs. Ambient Temperature

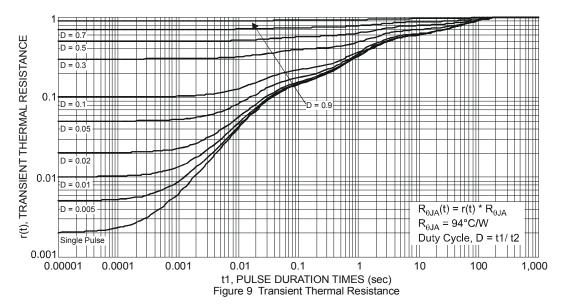




30 25 QUANCE DRAIN VOLTAGE (V)

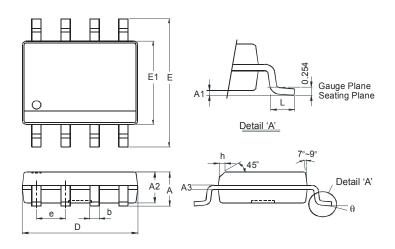
Figure 8 Diode Forward Voltage vs. Current





# **Package Outline Dimensions**

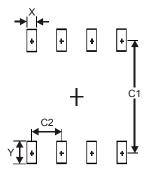
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SO-8						
Dim	Min	Max				
Α	-	1.75				
A1	0.10	0.20				
A2	1.30	1.50				
A3	0.15	0.25				
b	0.3	0.5				
D	4.85	4.95				
Е	5.90	6.10				
E1	3.85	3.95				
е	<b>e</b> 1.27 Typ					
h	1	0.35				
١	0.62	0.82				
θ	0°	8°				
All Dimensions in mm						

# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for latest version.



Dimensions	Value (in mm)		
Х	0.60		
Υ	1.55		
C1	5.4		
C2	1.27		



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